Photovoltaic and Thermal Effects at PbTe p-n Junction under CO₂ Laser Irradiation

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> In this work, two effects appeared in PbTe p-n junctions under long-wave irradiation by CO₂ laser were investigated. The first effect was created by the optical absorption of long-wave photons in PbTe and caused by its photovoltaic effect. The mechanism of photoeffect is connected with the formation of electron-hole pairs by two-photon processes of absorption and separation of pairs at the p-n junction. The second novel effect is related to the heating process and the formation of temperature difference at the p-n junction. The main feature of PbTe semiconductor is a strong temperature dependence of static dielectric constant ε . In this case, for PbTe p-n junction it was created a barrier pyroelectric effect. PbTe p-n junctions were fabricated employing indium donor diffusion into PbTe single crystals grown by the Chochrasky technique. Current-voltage and capacitancevoltage characteristics have been measured over a wide temperature range. The dark saturation current density was $\sim 10^{-7}$ A/cm² at T = 100 K. Two methods were used. The short-pulsed CO₂ laser light (with a pulse duration of 150 ns) across the PbTe p-n junction was used for the investigation of the photovoltaic effect. The continuous irradiation of CO₂ was used for the investigation of the thermal effect and caused by its barrier pyroelectric effect (BPE). These two effects were investigated over the 40–150 K temperature range.

Keywords: PbTe semiconductor, p.n junction, two-photon absorption, barrier pyroelectric effect.

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